



EQUIPMENT LIST CHEMICAL / PHYSICAL LABORATORY



Our extensive expertise and lengthy equipment list help us surmount even the biggest challenges in measurement technology.

Infrarot spectrometer	Technical data	Areas of application
	 Perkin Elmer Spectrum 65 Solid and liquid samples can be measured Recording range (wavenumber): 4000 cm-1 to 600 cm-1 Golden Gate Diamond ATR unit 5200 cm-1 to 650 cm-1 	 Comparison of spectra with reference samples Comparison of spectra with in-house database for material identification Plastic identification Silicone detection Detection and identification of functional groups Determination of low-volatility hydrocarbons

UN-Vis-NIR Spectrophotometer	Technical data	Areas of application
	 Varian Cary 500 Scan Wavelength range: 200–2500 nm Integrating sphere (250–2500 nm) 	Reflection measurement Transmission measurement



Thermogravimetrische analysis (TGA)	Technical data	Areas of application
	 Perkin Elmer TGA7 Weighing accuracy: up to 10 ppm Sample capacity: up to 50 μl Temperature range: ambient temperature up to 1000°C Heating and cooling rates: 0.1 to 200°C/min in 0.1°C steps 	 Determination of filling level for inorganic fillers in plastics (e. g., glass fibers) Thermal stability Outgassing

Differential scanning calorimetry (DSC)	Technical data	Areas of application
METTER TOLEDO	 Mettler-Toledo DSC5+ Temperature range: -90°C to 700°C Heating rate: 0.001 to 200 K/min Measuring method: Power Compensation or Heat Flux 	 Characterization of materials (melting point, glass transition, crystallization, phase transitions) Curing of adhesives (enthalpy, kinetics)



Thermomechanical analysis (TMA)	Technical data	Areas of application
MATTER TOKEO MA	 Mettler Toledo TMA/SDTA 2+ IC/600 Temperature range: -80°C to 600°C Maximum sample length: 20 mm Measuring range (length): -5 mm to 5 mm Force range: -0.1 N to 1 N Length resolution: 0.5 nm 	 Measurement of coefficients of linear expansion Glass transition temperature Young's modulus measurements

Sureface tension measuring device	Technical data	Areas of application
	 Surftens Basic Determination of surface tension by means of contact angle measurement 	Establishing surface condition with regard to good adhesion – for example, for adhesives and coatings



Rheometer	Technical data	Areas of application
	 Anton Paar MCR 302 Temperature range: -40°C to +200°C Cone plate Parallel plate Oscillation 	 Measurement of viscosity Determination of pot life Oscillation for the determination of loss and storage modulus, for example

Colorimeter	Technical data	Areas of application
TOTAL ADDRESS OF THE PARTY OF T	 CM-700d Spectrophotometer Color determination in the CIE L*a*b color space Standard illuminant D65 for daylight and F11 for artificial light Wavelength range: 400 nm to 700 nm 	 Color difference recognition Comparison with RAL colors



Gloss meter	Technical data	Areas of application
	 Reflektometer REFO 3 Glanzgradmesser für die Winkel 20°/60°/85° 	Quantitative Messmethode zur Bestimmung von Mattheit / Glanz

Coating thickness gauge	Technical data	Areas of application
	 Fischer Isoscope MP30 Eddy current-coating thickness gauge Measuring range from 10μm to 1000μm 	Eddy current probe for measuring thickness of electrically non-conductive coatings on non-ferrous metals (Iso/NF)



pH / conductometer	Technical data	Areas of application
	 Metrohm 914 pH/Conductometer pH range: -13.000-+20.000 Conductivity range: 0.1μS-500 mS 	 pH/Conductivity meter for measuring pH/mV/conductivity/TDS/salinity and temperature Example: wastewater analysis

Digital measuring projector	Technical data	Areas of application
	 Keyence IM 8030 T Precision measurement mode: Field of view: 225 x 125 mm (standard measuring mode 300 x 200 mm) Measuring accuracy (±2σ): ±2 μm Repeatability: ±0.5 μm Additional measuring options: Light sensor measurement Height measurement probe 	 Automated measurements Dimensional accuracy checks Dimensional accuracy checks Measurement of references in multiple axes



Interferometer	Technical data	Areas of application
Verifire HDD	 Zygo Verifire™ HDX Optical aperture: 6" Reference flat: 6" Ultraflat Resolution: 11.6 MPix 	 Plane mirror surface deviations Wavefront error in optical systems

Refractometer	Technical data	Areas of application
METTER TOLEDO	 Mettler Toledo Refractometer Excellence R4 Calculation index range: 1.32 - 1.70 Temperature range: 0 - 100°C 	 Measurement of the calculation index of liquid samples Measurement of the calculation index of thin films